

新普科技股份有限公司  
新世電子(常熟)有限公司  
新普科技(重慶)有限公司  
兆普電子(上海)有限公司

Control Number : SLEU-1210001

## UN38.3 Test Report

### Recommendations on the TRANSPORT OF DANGEROUS GOODS

(Manual of Tests and Criteria, Fifth revised edition)


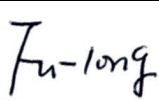

**Customer : Lenovo**

**Model : ASM P/N 45N1138**

**FRU P/N 45N1139**

**LC P/N 121500158**

**Rating : 14.8V , 3.1Ah / 46Wh**

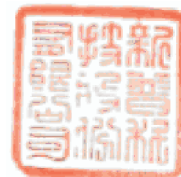
Approved By	Checked By	Prepared By
		

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## 1. Purpose of the Test :

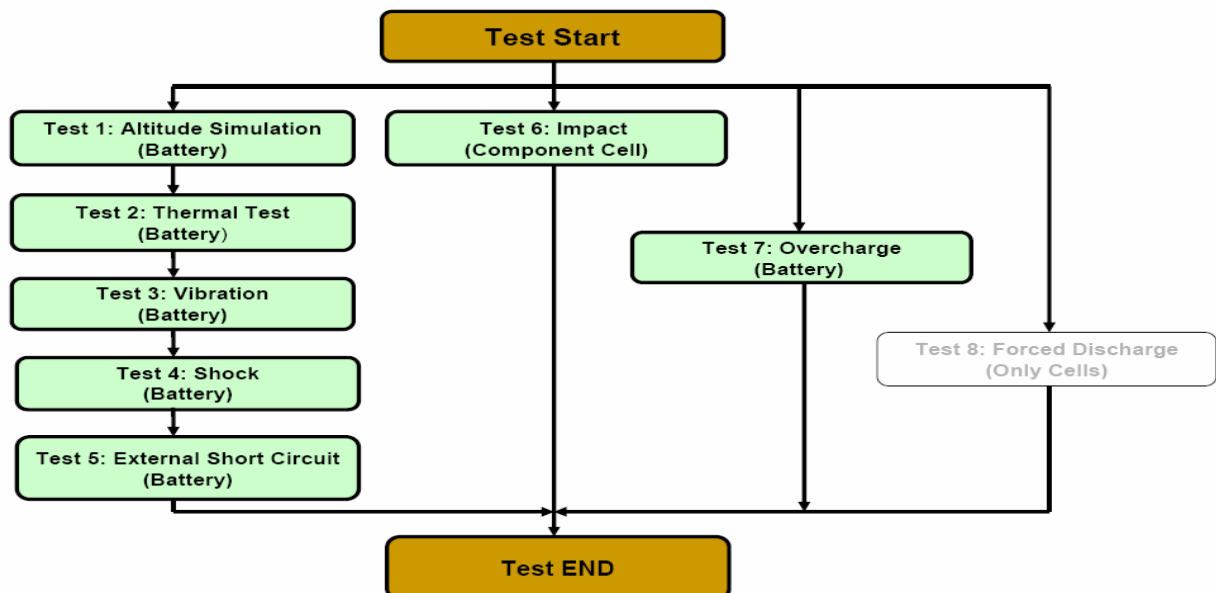
To test each cell/battery is of the type proved to meet the requirements in the Recommendations on the TRANSPORT OF DANGEROUS GOODS, Manual of Tests and Criteria, Fifth revised edition.

## 2. Test Quantity :

- 2.1 Four batteries, at first cycle, in fully charged states. (for T.1~T.5 test)
- 2.2 Four batteries, after fifty cycles ending in fully charged states. (for T.1~T.5 test)
- 2.3 Ten component cells, at first cycle at 50% of the design rated capacity. (for T.6 test)
- 2.4 Four batteries, at first cycle, in fully charged states. (for T.7 test)
- 2.5 Four batteries, after fifty cycles ending in fully charged states. (for T.7 test)

## 3. Test Procedure :

- 3.1 All detail related test procedure shall be follow TRANSPORT OF DANGEROUS GOODS, Manual of Tests and Criteria, Fifth revised edition.
- 3.2 Test flow shall be follow below statement.





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#### 4. Test Result :

##### 4.1 T.1 ~T.4 Test results: **Pass**

4.1.1 All batteries could meet the requirement, mass loss less than 0.1% and voltage drop less than 10% after the test.

4.1.2 No leakage, no venting, no disassembly, no rupture and no fire.

##### 4.2 T.5 Test results: **Pass**

4.2.1 All batteries could meet the requirement, external temperature did not exceed 170°C.

4.2.2 All batteries were no disassembly, no rupture and no fire during the test and within six hours after the test.

##### 4.3 T.6 Test results: **Pass**

4.3.1 All component cells could meet the requirement, external temperature did not exceed 170°C.

4.3.2 All component cells were no disassembly and no fire during the test and within six hours after the test.

##### 4.4 T.7 Test result: **Pass**

4.4.1 All batteries could meet no disassembly and no fire during the test and within seven days after the test.



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Control Number : SLEU-1210001

## 5. Test Equipment :

**SMP** SIMPLO TECHNOLOGY CO., LTD.

Revised date: 2012-10-05

Address : No. 471, Sec.2, Pa Teh Rd., Hu Kou, Hsin Chu Hsien 303 Taiwan

Date: 2012-10-05

TEL: +886-3-5695920; FAX: +886-3-5695931

Project No.: ASM P/N 45N1138 4S1P

**Test Instruments Reference List**

Used	Instrument ID	Instrument Name	Type	Range Used	Manufacturer	Calibration Date_Last	Calibration Date_Next	Remarks
	<b>Pretest</b>							
V	ML-761	Learning	715C	0~18V 0~8A	SMP	2012/5/25	2013/5/25	
V	ML-762	Learning	715C	0~18V 0~8A	SMP	2012/6/5	2013/6/5	
V	ML-763	Learning	715C	0~18V 0~8A	SMP	2012/6/13	2013/6/13	
	<b>T.1 Altitude Simulation</b>							
V	ML-522	Altitude		Kpa:30~90	新匠	2012/8/31	2013/8/31	
V	ML-257	Multimeter	HP 34401A	Note 1	Agilent	2012/7/6	2013/7/6	
V	ML-494	Electronic Balance	XS1220M-SCS	1-1000 gf	CHUANHUA	2012/8/31	2013/8/31	
V	ML-550	Data Logger	313	15~35 °C ; 30~80 %RH	CENTER	2011/11/16	2012/11/16	
	<b>T.2 Thermal Test</b>							
V	ML-018	Thermal Shock	WSF-602	T:-40 to 120°C	WIT	2012/1/31	2013/1/31	
V	ML-257	Multimeter	HP 34401A	Note 1	Agilent	2012/7/6	2013/7/6	
V	ML-494	Electronic Balance	XS1220M-SCS	1-1000 gf	CHUANHUA	2012/8/31	2013/8/31	
	<b>T.3 Vibration</b>							
V	ML-233	Vibration	KD-9636-EM-300F2K-30N80	F:5~2000Hz G:0.2~20G	King Design	2011/11/7	2012/11/7	
V	ML-257	Multimeter	HP 34401A	Note 1	Agilent	2012/7/6	2013/7/6	
V	ML-494	Electronic Balance	XS1220M-SCS	1-1000 gf	CHUANHUA	2012/8/31	2013/8/31	
V	ML-552	Data Logger	313	15~35 °C ; 30~80 %RH	CENTER	2011/11/16	2012/11/16	
	<b>T.4 Shock</b>							
V	ML-056	Shock	DP-1200-25	G:10~600G	King Design	2011/11/7	2012/11/7	
V	ML-257	Multimeter	HP 34401A	Note 1	Agilent	2012/7/6	2013/7/6	
V	ML-494	Electronic Balance	XS1220M-SCS	1-1000 gf	CHUANHUA	2012/8/31	2013/8/31	
V	ML-551	Data Logger	313	15~35 °C ; 30~80 %RH	CENTER	2011/11/16	2012/11/16	
	<b>T.5 External Short Circuit</b>							
V	ML-534	mΩ Hifester	3540	1mΩ ~ 30kΩ	YEOW LONG	2011/11/2	2012/11/2	
V	ML-339	Data Acquisition	MX100-E-1D	1-100 Vdc, -50 to 150°C	Yokogawa	2012/6/27	2013/6/27	
V	ML-521	Chamber	WIT IPC-1000(3F)	-20 to 150°C	WIT	2011/11/11	2012/11/11	
	<b>T.6 Impact ( Component cell )</b>							
V	ML-340	Data Acquisition	MX100-E-1D	1-100 Vdc, -50 to 150°C	Yokogawa	2011/11/2	2012/11/2	
V	ML-076	Impact Tester			JYI SHENG	2012/1/31	2013/1/31	
	<b>T.7 Overcharge</b>							
V	ML-481	Power Supply	DS10014	1-100Vdc, 0.3-14.4A	MOTECH	2012/6/27	2013/6/27	
V	ML-482	Power Supply	DS10014	1-100Vdc, 0.3-14.4A	MOTECH	2012/6/27	2013/6/27	
V	ML-483	Power Supply	DS10014	1-100Vdc, 0.3-14.4A	MOTECH	2012/6/27	2013/6/27	
V	ML-484	Power Supply	DS10014	1-100Vdc, 0.3-14.4A	MOTECH	2012/6/27	2013/6/27	
V	ML-485	Power Supply	DS10014	1-100Vdc, 0.3-14.4A	MOTECH	2012/6/27	2013/6/27	
V	ML-486	Power Supply	DS10014	1-100Vdc, 0.3-14.4A	MOTECH	2012/6/27	2013/6/27	
V	ML-487	Power Supply	DS6024	1-60 Vdc, 0.3-24A	MOTECH	2012/6/27	2013/6/27	
V	ML-488	Power Supply	DS6024	1-60 Vdc, 0.3-24A	MOTECH	2012/6/27	2013/6/27	
V	ML-489	Power Supply	DS6024	1-60 Vdc, 0.3-24A	MOTECH	2012/6/27	2013/6/27	
V	ML-490	Power Supply	DS6024	1-60 Vdc, 0.3-24A	MOTECH	2012/6/27	2013/6/27	
V	ML-549	Data Logger	313	15~35 °C ; 30~80 %RH	CENTER	2011/11/16	2012/11/16	

Note 1: DC Voltage: 0.1-1000V; AC Voltage: 0.5-700V at 60Hz, 1kHz; Resistance: 10Ω-10MΩ; DC Current: 0.1mA-3A; AC Current: 0.01-3A at 60Hz, 0.01-1A, at 1kHz.

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Control Number : SLEU-1210001

## 6. T.1~T.7 Detail Reports:

Control No.: SLEU-1210001

UN 38.3 Test Datasheet

Customer: Lenovo

Model name: ASM P/N 45N1138 4S1P

Test duration: 2012/09/11~2012/10/05

Reviewer: Esmond

Test Sample Identification:

Used	Sample No.	Sample State	Used	Sample No.	Sample State	Used	Sample No.	Sample State
V	01~04	1 Cycle, Fully charged	V	05~08	50 Cycle, Fully charged			25Cycle, Fully charged
V	09~12	1 Cycle, Fully charged	V	13~16	50 Cycle, Fully charged			25Cycle, Fully charged
V	01C~10C	1 Cycle, 50% charged			1 Cycle, 50% charged			

### T.1 Altitude Simulation

Start time: 09 / 24 / 08 : 26  
Finish time: 09 / 24 / 14 : 43

Ambient temp.: 24.6 ℃

Operator: Betty

Reviewer: Esmond

Sample No.: 01					Sample No.: 05						
	Before	After	Variation		Results		Before	After	Variation		Results
Mass (g)	240.3	240.3	Mass loss %	0.00%	P	Mass (g)	240.6	240.5	Mass loss %	0.04%	P
OCV (V)	16.73	16.73	Remained OCV%	100.00%		OCV (V)	16.73	16.73	Remained OCV%	100.00%	
Sample No.: 02					Sample No.: 06						
	Before	After	Variation		Results		Before	After	Variation		Results
Mass (g)	240.5	240.5	Mass loss %	0.00%	P	Mass (g)	240.3	240.2	Mass loss %	0.04%	P
OCV (V)	16.73	16.73	Remained OCV%	100.00%		OCV (V)	16.72	16.72	Remained OCV%	100.00%	
Sample No.: 03					Sample No.: 07						
	Before	After	Variation		Results		Before	After	Variation		Results
Mass (g)	240.3	240.3	Mass loss %	0.00%	P	Mass (g)	240.5	240.4	Mass loss %	0.04%	P
OCV (V)	16.72	16.71	Remained OCV%	99.94%		OCV (V)	16.73	16.73	Remained OCV%	100.00%	
Sample No.: 04					Sample No.: 08						
	Before	After	Variation		Results		Before	After	Variation		Results
Mass (g)	240.6	240.6	Mass loss %	0.00%	P	Mass (g)	240.6	240.5	Mass loss %	0.04%	P
OCV (V)	16.73	16.73	Remained OCV%	100.00%		OCV (V)	16.73	16.72	Remained OCV%	99.94%	

### T.2 Thermal Test

Start time: 09 / 24 / 15 : 21  
Finish time: 10 / 01 / 10 : 36

Ambient temp.: 24.2 ℃

Operator: Betty

Reviewer: Esmond

Sample No.: 01					Sample No.: 05						
	Before	After	Variation		Results		Before	After	Variation		Results
Mass (g)	240.3	240.2	Mass loss %	0.04%	P	Mass (g)	240.5	240.4	Mass loss %	0.04%	P
OCV (V)	16.73	16.47	Remained OCV%	98.45%		OCV (V)	16.73	16.47	Remained OCV%	98.45%	
Sample No.: 02					Sample No.: 06						
	Before	After	Variation		Results		Before	After	Variation		Results
Mass (g)	240.5	240.5	Mass loss %	0.00%	P	Mass (g)	240.2	240.1	Mass loss %	0.04%	P
OCV (V)	16.73	16.46	Remained OCV%	98.39%		OCV (V)	16.72	16.46	Remained OCV%	98.44%	
Sample No.: 03					Sample No.: 07						
	Before	After	Variation		Results		Before	After	Variation		Results
Mass (g)	240.3	240.2	Mass loss %	0.04%	P	Mass (g)	240.4	240.3	Mass loss %	0.04%	P
OCV (V)	16.71	16.43	Remained OCV%	98.32%		OCV (V)	16.73	16.46	Remained OCV%	98.39%	
Sample No.: 04					Sample No.: 08						
	Before	After	Variation		Results		Before	After	Variation		Results
Mass (g)	240.6	240.6	Mass loss %	0.00%	P	Mass (g)	240.5	240.4	Mass loss %	0.04%	P
OCV (V)	16.73	16.46	Remained OCV%	98.39%		OCV (V)	16.72	16.44	Remained OCV%	98.33%	

### T.3 Vibration

Start time: 10 / 01 / 11 : 42  
Finish time: 10 / 02 / 10 : 17

Ambient temp.: 24.5 ℃

Operator: Betty

Reviewer: Esmond

Sample No.: 01					Sample No.: 05						
	Before	After	Variation		Results		Before	After	Variation		Results
Mass (g)	240.2	240.1	Mass loss %	0.04%	P	Mass (g)	240.4	240.3	Mass loss %	0.04%	P
OCV (V)	16.47	16.46	Remained OCV%	99.94%		OCV (V)	16.47	16.46	Remained OCV%	99.94%	
Sample No.: 02					Sample No.: 06						
	Before	After	Variation		Results		Before	After	Variation		Results
Mass (g)	240.5	240.4	Mass loss %	0.04%	P	Mass (g)	240.1	240.1	Mass loss %	0.00%	P
OCV (V)	16.46	16.46	Remained OCV%	100.00%		OCV (V)	16.46	16.46	Remained OCV%	100.00%	
Sample No.: 03					Sample No.: 07						
	Before	After	Variation		Results		Before	After	Variation		Results
Mass (g)	240.2	240.2	Mass loss %	0.00%	P	Mass (g)	240.3	240.2	Mass loss %	0.04%	P
OCV (V)	16.43	16.42	Remained OCV%	99.94%		OCV (V)	16.46	16.46	Remained OCV%	100.00%	
Sample No.: 04					Sample No.: 08						
	Before	After	Variation		Results		Before	After	Variation		Results
Mass (g)	240.6	240.5	Mass loss %	0.04%	P	Mass (g)	240.4	240.4	Mass loss %	0.00%	P
OCV (V)	16.46	16.46	Remained OCV%	100.00%		OCV (V)	16.44	16.44	Remained OCV%	100.00%	

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Control Number : SLEU-1210001

T.4 Shock Start time: 10 / 02 / 13 : 27 Ambient temp.: 24.3 ℃ Operator: Betty Reviewer: Esmond  
Finish time: 10 / 02 / 15 : 36

Sample No.: 01					Sample No.: 05				
Before	After	Variation		Results	Before	After	Variation		Results
Mass (g)	240.1	240.1	Mass loss %	0.00%	Mass (g)	240.3	240.3	Mass loss %	0.00%
OCV (V)	16.46	16.46	Remained OCV%	100.00%	OCV (V)	16.46	16.45	Remained OCV%	99.94%
P					P				
Sample No.: 02					Sample No.: 06				
Before	After	Variation		Results	Before	After	Variation		Results
Mass (g)	240.4	240.3	Mass loss %	0.04%	Mass (g)	240.1	240.0	Mass loss %	0.04%
OCV (V)	16.46	16.46	Remained OCV%	100.00%	OCV (V)	16.46	16.46	Remained OCV%	100.00%
P					P				
Sample No.: 03					Sample No.: 07				
Before	After	Variation		Results	Before	After	Variation		Results
Mass (g)	240.2	240.2	Mass loss %	0.00%	Mass (g)	240.2	240.1	Mass loss %	0.04%
OCV (V)	16.42	16.42	Remained OCV%	100.00%	OCV (V)	16.46	16.45	Remained OCV%	99.94%
P					P				
Sample No.: 04					Sample No.: 08				
Before	After	Variation		Results	Before	After	Variation		Results
Mass (g)	240.5	240.5	Mass loss %	0.00%	Mass (g)	240.4	240.4	Mass loss %	0.00%
OCV (V)	16.46	16.46	Remained OCV%	100.00%	OCV (V)	16.44	16.43	Remained OCV%	99.94%
P					P				

T.5 External Short Circuit Start time: 10 / 02 / 16 : 51 Ambient temp.: 25.6 ℃ Operator: Betty Reviewer: Esmond  
Finish time: 10 / 03 / 08 : 27

	Sample No.: 01		Sample No.: 02		Sample No.: 03		Sample No.: 04		Sample No.: 05		Sample No.: 06		Sample No.: 07		Sample No.: 08	
Resistance (<100mΩ)	53.6		51.5		53.4		56.8		57.9		54.6		56.7		60.3	
OCV before test after short circuit(V)	16.46	0.00	16.46	0.00	16.42	0.00	16.46	0.00	16.45	0.00	16.46	0.00	16.45	0.00	16.43	0.00
Max Temp. (< 170℃)	55.3		55.3		55.2		55.3		55.3		55.2		55.2		55.3	
Results	P		P		P		P		P		P		P		P	

T.6 Impact (Component cell) Start time: 09 / 27 / 15 : 54 Ambient temp.: 24.8 ℃ Operator: Betty Reviewer: Esmond  
Finish time: 09 / 28 / 08 : 37

	Sample No.: 01C	Sample No.: 02C	Sample No.: 03C	Sample No.: 04C	Sample No.: 05C
OCV before test(V)	3.70	3.70	3.69	3.70	3.70
Max Temp. (< 170℃)	91.7	93.4	95.5	92.8	92.9
Results	P	P	P	P	P
	Sample No.: 06C	Sample No.: 07C	Sample No.: 08C	Sample No.: 09C	Sample No.: 10C
OCV before test(V)	3.69	3.70	3.69	3.69	3.69
Max Temp. (< 170℃)	93.3	95.7	93.9	93.4	96.7
Results	P	P	P	P	P

T.7 Overcharge Start time: 09 / 28 / 08 : 43 Ambient temp.: 24.2 ℃ Operator: Betty Reviewer: Esmond  
Finish time: 10 / 05 / 14 : 36

	Sample No.: 09	Sample No.: 10	Sample No.: 11	Sample No.: 12	Sample No.: 13	Sample No.: 14	Sample No.: 15	Sample No.: 16
OCV before test(V)	16.73	16.73	16.73	16.72	16.73	16.72	16.73	16.73
Results	P	P	P	P	P	P	P	P

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Control Number : SLEU-1210001

## 7. Equipment for Test:



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